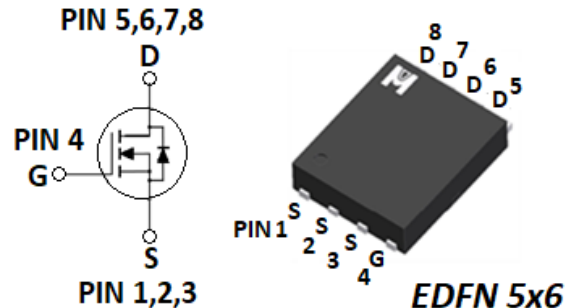


Single N-Channel Logic Level Enhancement Mode Field Effect Transistor
▪ Product Summary:

	N-CH
BV_{DSS}	30V
$R_{DS(on) (MAX.)}@V_{GS}=10V$	4.0m Ω
$R_{DS(on) (MAX.)}@V_{GS}=4.5V$	5.0m Ω
$I_D @T_C=25^{\circ}C$	138A
$I_D @T_A=25^{\circ}C$	19A

▪ Pin Description:


Single N Channel MOSFET

UIS, Rg 100% Tested

RoHS & Halogen Free & TSCA Compliant


▪ ABSOLUTE MAXIMUM RATINGS ($T_C = 25^{\circ}C$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNIT
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current ¹	$T_C = 25^{\circ}C$	I_D	138	A
	$T_C = 100^{\circ}C$		87	
Continuous Drain Current ¹	$T_A = 25^{\circ}C$		19	
	$T_A = 70^{\circ}C$		15	
Pulsed Drain Current ¹		I_{DM}	200	
Avalanche Current ^{1,4}		I_{AS}	53	mJ
Avalanche Energy ^{1,4}	$L = 0.1mH$	E_{AS}	140	
Repetitive Avalanche Energy ^{2,4}	$L = 0.05mH$	E_{AR}	70	
Power Dissipation ¹	$T_C = 25^{\circ}C$	P_D	125	W
	$T_C = 100^{\circ}C$		50	
Power Dissipation ¹	$T_A = 25^{\circ}C$	P_D	2.4	W
	$T_A = 70^{\circ}C$		1.5	
Operating Junction & Storage Temperature Range		T_J, T_{stg}	-55 to 150	$^{\circ}C$

◆100% UIS testing in condition of $V_D=25V$, $L=0.1mH$, $V_G=10V$, $I_L=32A$, $R_G=25\Omega$, Rated $V_{DS}=30V$ N-CH

▪ THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case		$R_{\theta JC}$		1.0	$^{\circ}C / W$
Junction-to-Ambient ³	$t \leq 10s$	$R_{\theta JA}$		19	
	Steady-State	$R_{\theta JA}$		52	

¹Pulse width limited by maximum junction temperature.

²Duty cycle < 1%

³The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}C$.

⁴Guarantee by Engineering test

▪ ELECTRICAL CHARACTERISTICS ($T_J = 25\text{ }^{\circ}\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage ⁴	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	30			V
Gate Threshold Voltage ⁴	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	1.2	1.6	2.5	
Gate-Body Leakage ⁴	I _{GSS}	V _{DS} = 0V, V _{GS} = ±20V			±100	nA
Zero Gate Voltage Drain Current ⁴	I _{DSS}	V _{DS} = 30V, V _{GS} = 0V			1	μA
		V _{DS} =30V, V _{GS} =0V, T _J = 125 °C			25	
On-State Drain Current ¹	I _{D(ON)}	V _{DS} = 10V, V _{GS} = 10V	138			A
Drain-Source On-State Resistance ^{1,4}	R _{DS(ON)}	V _{GS} = 10V, I _D = 30A		3.0	4.0	mΩ
		V _{GS} = 4.5V, I _D = 24A		3.8	5.0	
Forward Transconductance ¹	g _{fs}	V _{DS} = 5V, I _D = 20A		100		S
DYNAMIC						
Input Capacitance ⁵	C _{iss}	V _{GS} = 0V, V _{DS} = 15V, f = 1MHz		2550		pF
Output Capacitance ⁵	C _{oss}			345		
Reverse Transfer Capacitance ⁵	C _{rss}			200		
Gate Resistance ^{4,5}	R _g	f = 1MHz		1.5		Ω
Total Gate Charge ^{1,2,5}	Q _g (V _{GS} =10V)	V _{DS} = 15V, V _{GS} = 10V, I _D = 30A		50		nC
	Q _g (V _{GS} =4.5V)			22		
Gate-Source Charge ^{1,2,5}	Q _{gs}			9.1		
Gate-Drain Charge ^{1,2,5}	Q _{gd}			7.5		
Turn-On Delay Time ^{1,2,5}	t _{d(on)}	V _{DS} = 15V, V _{GS} = 10V, I _D = 5A , R _g = 3Ω		7.5		nS
Rise Time ^{1,2,5}	t _r			11		
Turn-Off Delay Time ^{1,2,5}	t _{d(off)}			40		
Fall Time ^{1,2,5}	t _f			20		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Continuous Current	I _S				104	A
Pulsed Current ³	I _{SM}				200	
Forward Voltage ^{1,4}	V _{SD}	I _F = 30A, V _{GS} = 0V			1.2	V
Reverse Recovery Time ⁵	t _{rr}	I _F =30A, dI _F /dt = 100A / μS		15		nS
Peak Reverse Recovery Current ⁵	I _{RM(REC)}			0.7		A
Reverse Recovery Charge ⁵	Q _{rr}			5.0		nC

¹Pulse test : Pulse Width $\leq 300\text{ usec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

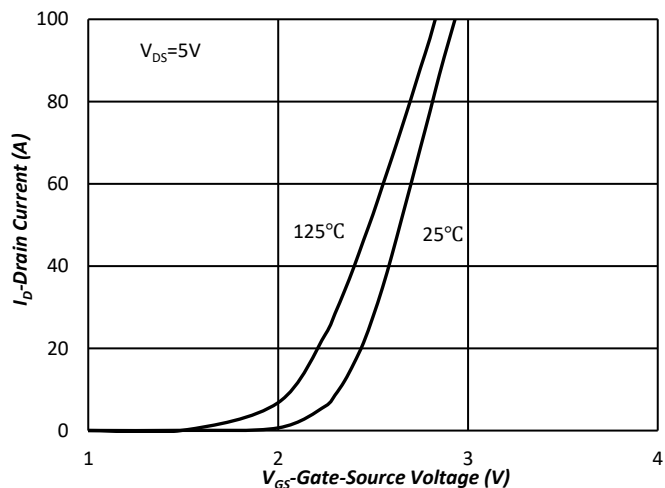
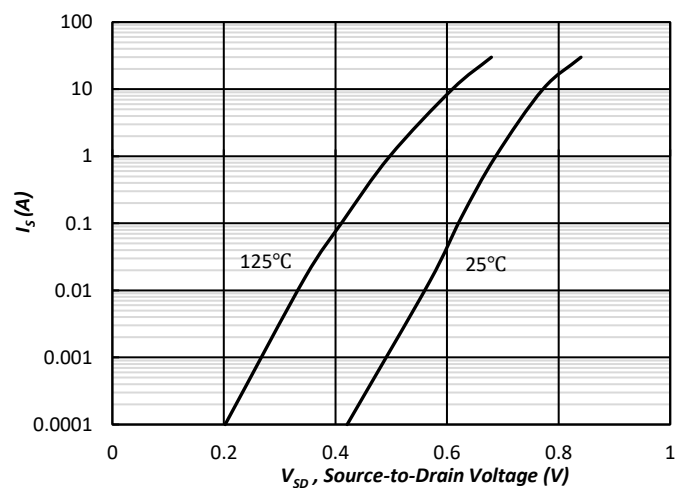
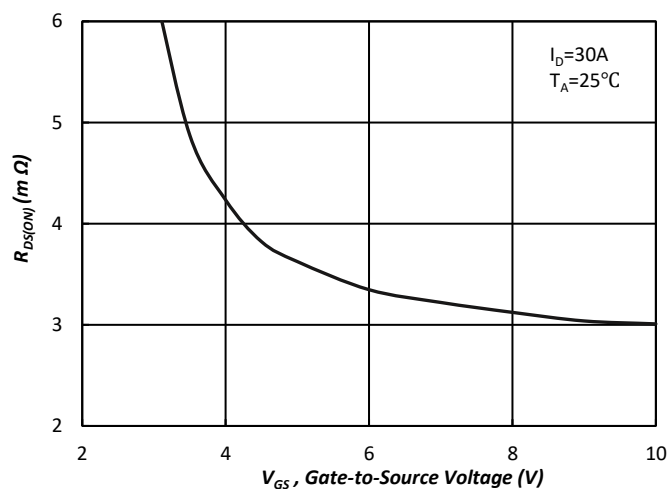
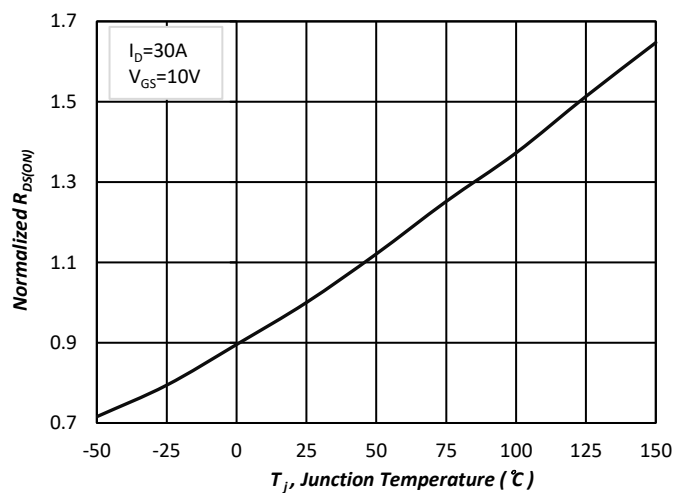
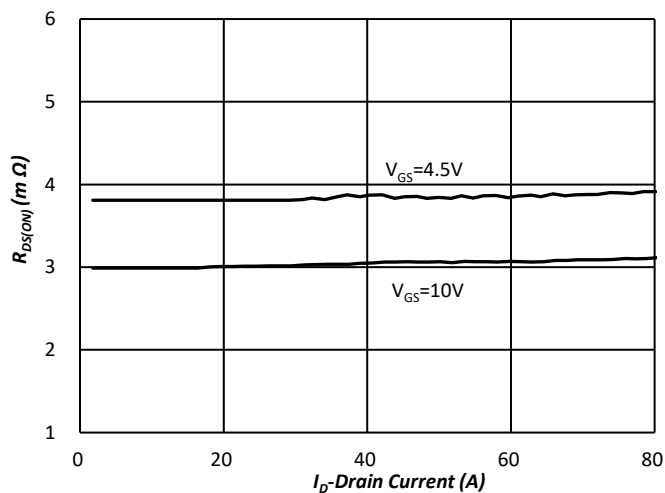
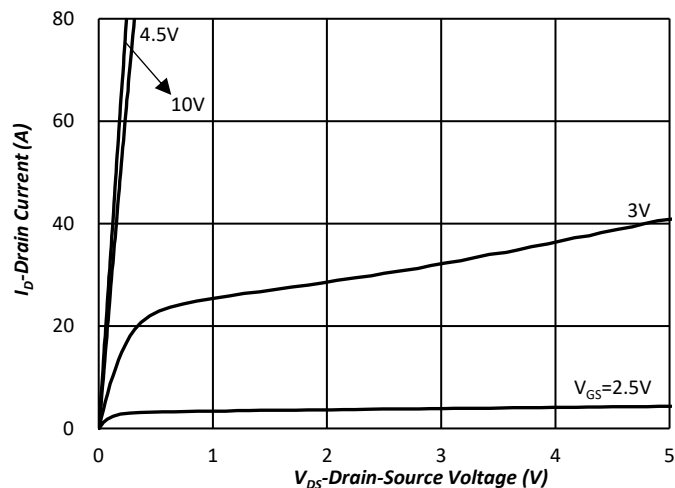
³Pulse width limited by maximum junction temperature.

⁴Guarantee by FT test Item

⁵Guarantee by Engineering test

EMC will review datasheet by quarter, and update new version.

•TYPICAL CHARACTERISTICS



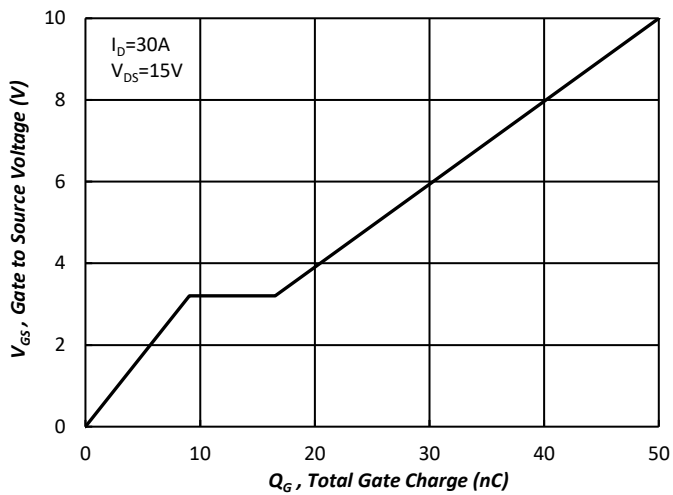


Fig.7 Gate Charge Characteristics

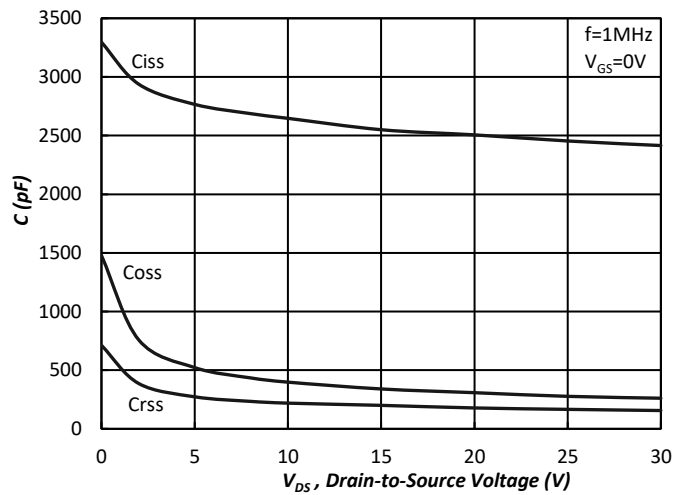


Fig.8 Typical Capacitance Characteristics

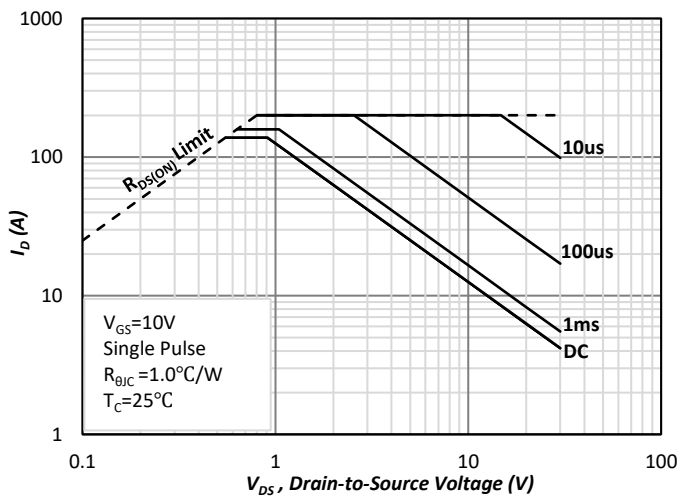


Fig.9. Maximum Safe Operating Area

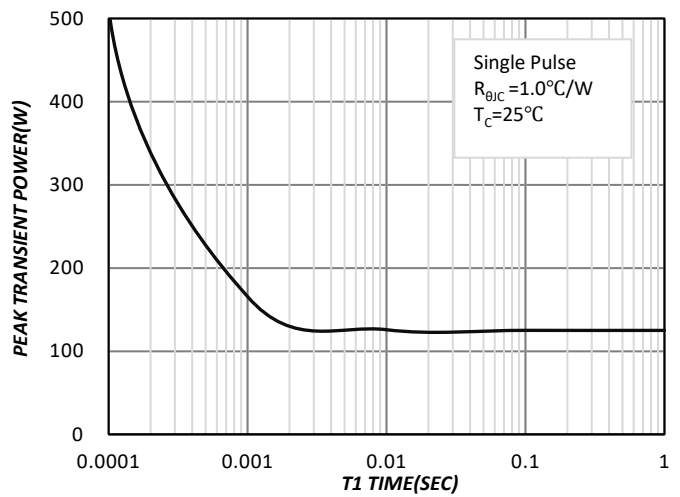


Fig.10. Single Pulse Maximum Power Dissipation

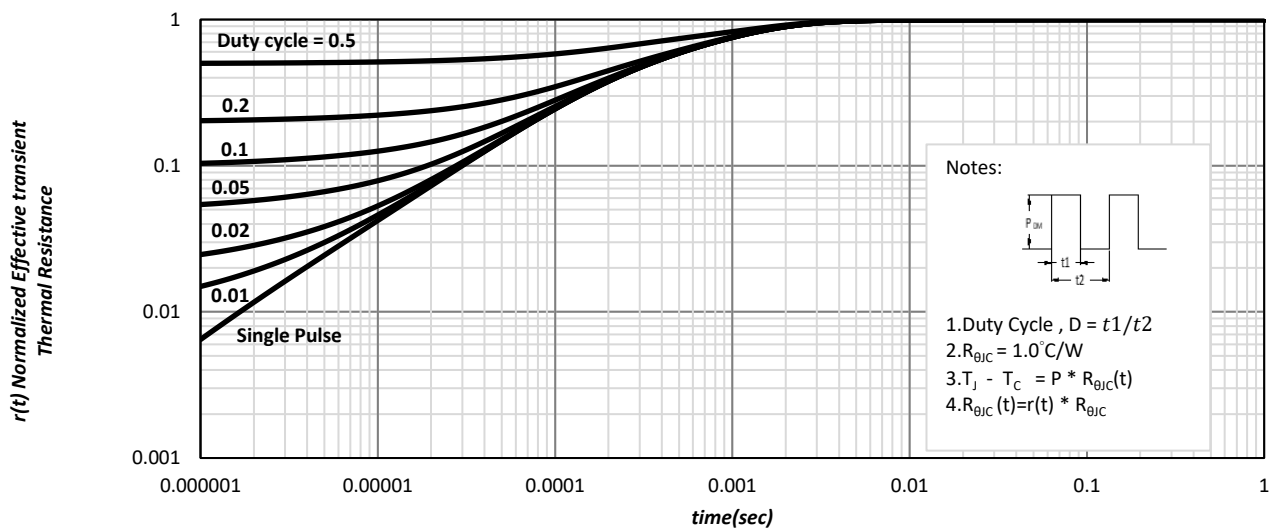


Fig.11. Effective Transient Thermal Impedance

Ordering & Marking Information:

Device Name: EMB04N03HR for EDFN 5x6



B04N03R: Device Name

ABCDEFG: Date Code

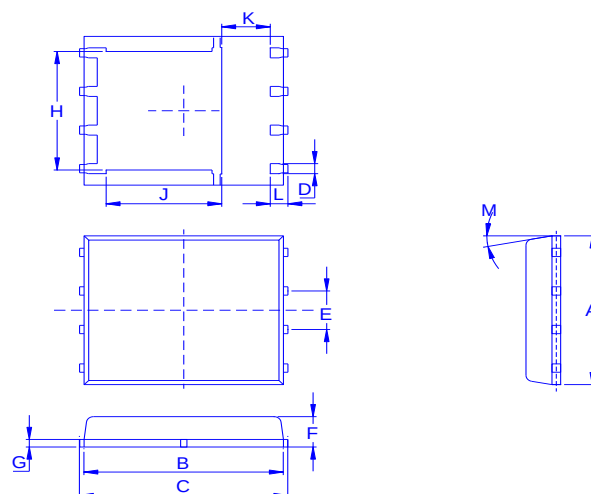
A: Assembly House

B: Year(A:2008 B:2009 C:2010....)

C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)

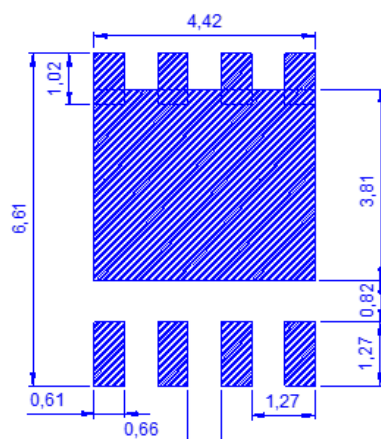
DEFG: Serial No.

Outline Drawing

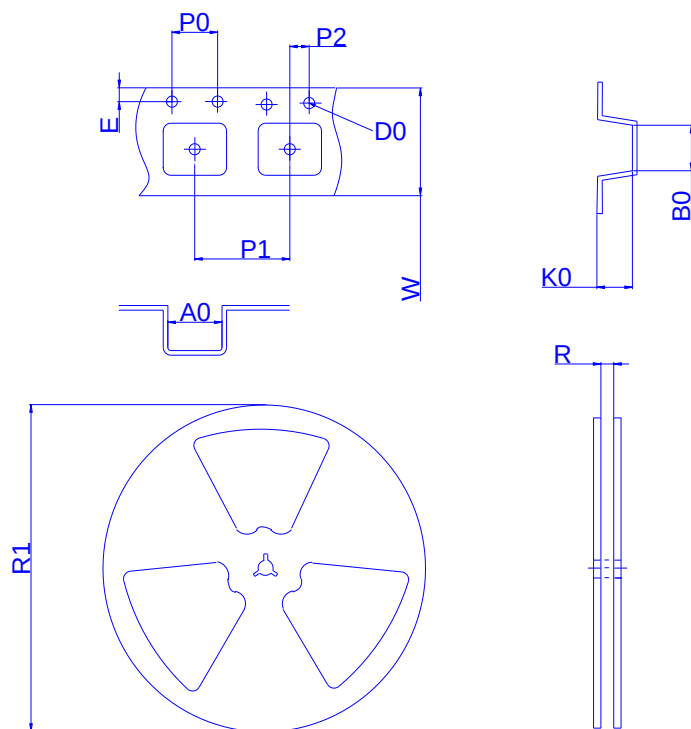


Dimension	A	B	C	D	E	F	G	H	J	K	L	M
Min	4.80	5.55	5.90	0.30	1.17	0.85	0.15	3.61	3.18	1.00	0.38	0°
Typ.	4.90	5.70	6.00	0.40	1.27	0.95	0.20	3.87	3.44	1.20	0.40	
Max	5.40	5.85	6.15	0.51	1.37	1.17	0.34	4.31	3.78	1.39	0.71	12°

Footprint



◆ Tape&Reel Information:2500pcs/Reel



Package	EDFN5X6
Reel	13"
Device orientation	FEED DIRECTION

Dimension in mm

Dimension	Carrier tape									Reel	
	A0	B0	D0	E	K0	P0	P1	P2	W	R	R1
Typ.	6.4	5.3	1.5	1.8	1.6	4	8	2	12	12.4	330
±	0.2	0.2	0.1	0.1	0.6	0.1	0.1	0.1	0.3	2	2